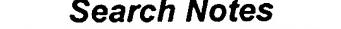


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/659,587	JUNG ET AL.	
	Examiner Sang Nguyen	Art Unit 2877	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner